

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,843	GOOD ET AL.	
Examiner	Art Unit	
Ryan A. Jarrett	2125	

SEARCHED					
Class	Subclass	Date	Examiner		
700	109-110,		1		
702	81-84,	1/8/05	2)		
			0		
	•		-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		·		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST - inventor - text IEEE	6/8/05	H	
-			
	·		